

Notice of References Cited

Application/Control No.
09/702,289

Applicant(s)/Patent Under
Reexamination
CHEN ET AL.

Examiner
Todd M Jack

Art Unit
2132

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U.S. PATENT DOCUMENTS

* A	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	US-6,275,937 B1	08-2001	Hailpern et al.	713/188
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
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J	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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* U	www.trendmicro.com	01/1989
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